

FINAL PRODUCT/PROCESS CHANGE NOTIFICATION Generic Copy

31-JAN-2005

SUBJECT: ON Semiconductor Final Product/Process Change Notification #13898

TITLE: Final PCN for Qualification of VHVIC 7 and 8 Lead Pdip Devices at AIT

EFFECTIVE DATE: 01-Apr-2005

AFFECTED CHANGE CATEGORY: Subcontractor Assembly Site

AFFECTED PRODUCT DIVISION: Analog Products

ADDITIONAL RELIABILITY DATA: Available

Contact your local ON Semiconductor Sales Representative or

Ken Fergus <RRST50@onsemi.com>

SAMPLES: Contact your local ON Semiconductor Sales Representative or

Scott Brow <FFTGCB@onsemi.com>

FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION:

Contact Sales Representative or Scott Brow <FFTGCB@onsemi.com>

NOTIFICATION TYPE:

Final Product/Process Change Notification (FPCN)

Final change notification sent to customers. FPCNs are issued at least 60 days prior to implementation of the change.

ON Semiconductor will consider this change approved unless specific conditions of acceptance are provided in writing within 30 days of receipt of this notice. To do so, contact your local ON Semiconductor Sales Office.

DESCRIPTION AND PURPOSE:

This is a Final Product Change Notice (follow up to IPCN 13312) to make customers aware that Advanced Interconnect Technologies (AIT), located in Batam, Indonesia, is being qualified as a supplemental manufacturing source for capacity expansion of ON Semiconductor's VHVIC 8 and 7 lead PDIP products. These products are currently processed at ASE in Penang, Malaysia. The devices listed may be processed at either location upon expiration of this PCN.

Devices parameters will continue to meet all DataSheet specifications, and reliability will continue to meet or exceed ON Semiconductor standards.

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AIT is QS9000 and ISO9002 certified, and has been a qualified subcontractor for ON Semiconductor devices since 1990.

RELIABILITY DATA SUMMARY:

2	10ts	\circ f	NCD1002D	1	10+	\circ f	NCP1053P136
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Test	Condition	Interval	SS	Result
HTBB	600V, 125C		3x80	0/240
TC	-65C to 150C		3x80	0/240
HAST	131C, 18.8 psig, 85% RF		3x80	0/240
UHAST	131C, 18.8 psig, 85% RF		3x80	0/240

ELECTRICAL CHARACTERISTIC SUMMARY:

Datasheet specifications remain unchanged.

CHANGED PART IDENTIFICATION:

Parts marked with date code after 0511 may be sourced from either site.

AFFECTED DEVICE LIST (WITHOUT SPECIALS):

PART

NCP1000P

NCP1001P

NCP1001PG

NCP1002P

NCP1002PG

NCP1010AP065

NCP1010AP065G

NCP1010AP100

NCP1010AP130

NCP1011AP065

NCP1011AP100

NCP1011AP100G

NCP1011AP130

NCP1011AP130G

NCP1012AP065

NCP1012AP100

NCP1012AP133

NCP1013AP065

NCP1013AP065G

NCP1013AP100

NCP1013AP133

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NCP1014AP065

NCP1014AP065G

NCP1014AP100

NCP1014AP100G

NCP1050P100

NCP1050P136

NCP1050P44

NCP1051P100

NCP1051P136

NCP1051P44

NCP1052P100

NCP1052P136

NCP1052P44

NCP1053P100

NCP1053P136

NCP1053P136G

NCP1053P44

NCP1053XP136

NCP1054P100

NCP1054P136

NCP1054P44

NCP1055P100

NCP1055P100G

NCP1055P136

NCP1055P44

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